Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YU ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | Α | US-6,764,373 | 07-2004 | Osawa et al. | 446/175 |
| | В | US-2002/0063550 | 05-2002 | Chen et al. | 320/110 |
| | C | US-5,818,197 | 10-1998 | Miller et al. | 320/107 |
| | D | US-5,506,749 | 04-1996 | Matsuda, Kazuyuki | 361/683 |
| | Ε | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | - | US- | | | |
| | J | US- | | | |
| | κ | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | Z | | | | | |
| · | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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